Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/533,610	CHARPIER, JEAN-PIERRE	
Examiner	Art Unit	

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Sean Kayes

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Class	Subclass	Date	Examiner
368	37	8/6/2007	SK
368	28	8/6/2007	SK
368	35-36	8/6/2007	SK
368	38	8/6/2007	SK
Updated	Search	11/8/2007	SK

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Class	Subclass	Date	Examiner	
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East Search		8/6/2007	SK
Plus Search		8/6/2007	SK
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